

# MOS INTEGRATED CIRCUIT $\mu$ PD16700

## 256-OUTPUT TFT-LCD GATE DRIVER

#### **DESCRIPTION**

The  $\mu$  PD16700 is a TFT-LCD gate driver equipped with 256-output lines. It can output a high-gate scanning voltage in response to CMOS level input because it provided with a level-shift circuit inside the IC circuit. It can also drive the XGA/SXGA panel.

#### **FEATURES**

- CMOS level input (3.3 V)
- 256 outputs
- High-output voltage (VDD2-VEE2 = amplitude: 40 V MAX.)
- Capable of All-on outputting (/AO)

Remark /xxx indicates active low signal.

#### **ORDERING INFORMATION**

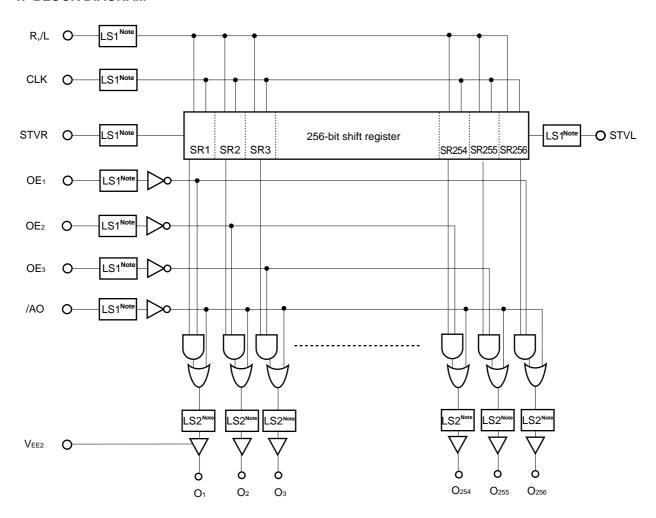
Part Number	Package
μ PD16700N-xxx	TCP (TAB package)

**Remark** The TCP's external shape is customized. To order the required shape, please contact an one of our sales representatives.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.

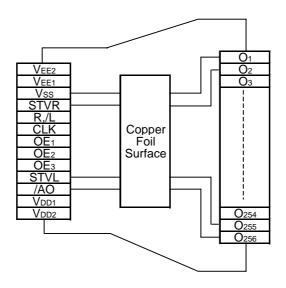
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

### 1. BLOCK DIAGRAM



Note LS1: shifts CMOS level and internal level, LS2: shifts interval level and output level (VDD2-VEE2).

# 2. PIN CONFIGURATION ( $\mu$ PD16700N-xxx : Copper Foil Surface, Face-up)



Remark This figure does not specify the TCP package.

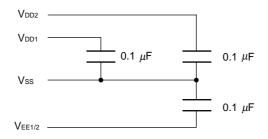
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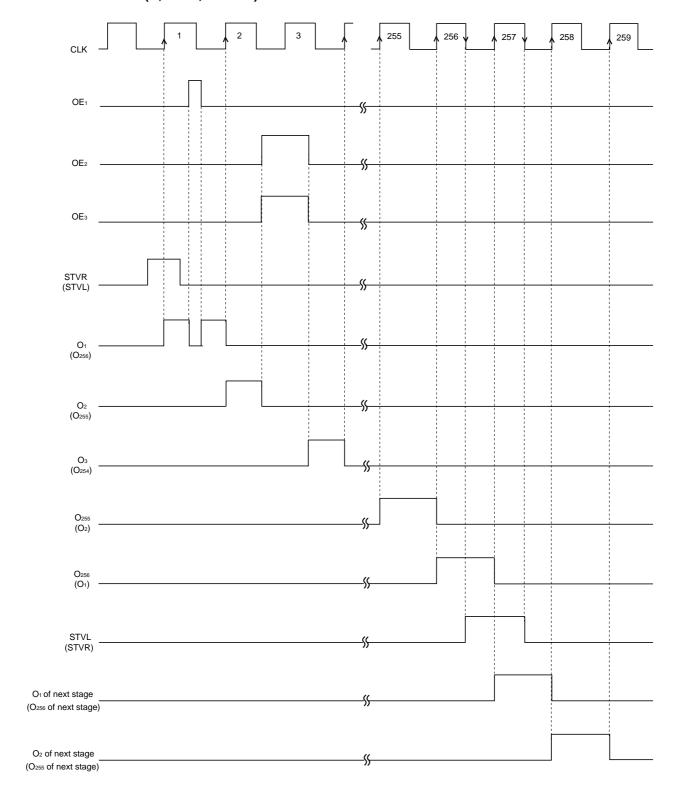
#### 3. PIN FUNCTIONS

	Pin Symbol	Pin Name	I/O	Description	
	O <sub>1</sub> to O <sub>256</sub>	Driver	0	These pins output scan signals that drive the vertical direction (gate lines) of a	
				TFT-LCD. The output signals change in synchronization with the rising edge of	
				shift clock (CLK). The driver output amplitude is VDD2 - VEE2.	
	R,/L	Shift direction select	1	Refers to the shift direction control. The shift directions of shift registers are as	
				follows.	
				R,/L = H (right shift) : STVR $\rightarrow$ O <sub>1</sub> $\rightarrow$ O <sub>256</sub> $\rightarrow$ STVL	
				$R_{\text{J}}/L = L \text{ (left shift)}: STVL \rightarrow O_{256} \rightarrow O_1 \rightarrow STVR$	
	STVR,	Start pulse	I/O	These refer to the input pins of the internal shift register. The start pulse is read	
	STVL			at the rising edge of CLK, and scan signals are output from the driver output pins.	
				The input level is a CMOS (3.3 V) level. The start pulse is output at the falling	
				edge of the 256th clock of CLK, and is cleared at the falling edge of the 257th	
*				clock. The output level is V <sub>DD1</sub> - V <sub>SS</sub> (logic level). The output level is a CMOS	
				level (3.3 V).	
	CLK	Shift clock	1	This pin inputs a shift clock to the internal shift register.	
				The shift operation is performed in synchronization with the rising edge of this	
				input.	
	OE <sub>1</sub> to OE <sub>3</sub>	Output enable	I	When these pins go H, the driver output is fixed to VEE2 level.	
*				The shift registers are not cleared. These pins are not synchronous with CLK.	
				OE1: O1, O4, O250, O253, O256	
				OE <sub>1</sub> : O <sub>2</sub> , O <sub>5</sub> , O <sub>251</sub> , O <sub>254</sub>	
				OE1: O3, O6, O252, O255	
_	/AO	All-on control	I	When this pin goes L, the driver output is fixed to VDD2 level. The shift register is	
*				not cleared. This pin has priority over OE1 to OE3. This pin is not synchronous	
				with CLK.	
	V <sub>DD1</sub>	Logic power supply	_	$3.3~\text{V}\pm0.3~\text{V}$	
	V <sub>DD2</sub>	Driver positive power	_	15 to 25 V	
		supply		The driver output : H level	
	Vss	Logic ground	-	Connect this pin to the ground of the system.	
	VEE1	Negative Power	_	–15 to –5 V	
		supply for internal			
		operation			
	VEE2	Driver negative	_	The driver output : L level (Vee2-Vee1 < 6.0 V)	
		power supply			

- Cautions 1. To prevent latch up, turn on power to VDD1, VEE1/2, VDD2, and logic input in this order. Turn off power in the reverse order. These power up/down sequence must be observed also during transition period.
  - 2. Insert a capacitor of about 0.1  $\mu$ F between each power line, as shown below, to secure noise margin such as V<sub>IH</sub> and V<sub>IL</sub>.



# 4. TIMING CHART (R,/L = H, /AO = H)



Data Sheet S14085EJ3V0DS 5



#### 5. ELECTRICAL SPECIFICATIONS

#### Absolute Maximum Ratings (TA = 25°C, Vss = 0 V)

Parameter	Symbol	Rating	Unit
Logic Supply Voltage	V <sub>DD1</sub>	-0.5 to +7.0	V
Driver Positive Supply Voltage	V <sub>DD2</sub>	-0.5 to +28	V
Power Supply Voltage	V <sub>DD2</sub> -V <sub>EE1</sub> , V <sub>EE2</sub>	-0.5 to +42	V
Internal Operation Negative Supply Voltage	V <sub>EE1</sub>	-16 to + 0.5	V
Driver Negative Supply Voltage	V <sub>EE2</sub>	$V_{EE1} - 0.3$ to $V_{EE1} + 7.0$	V
Input Voltage	Vı	-0.5 to V <sub>DD1</sub> + 0.5	V
Operating Ambient Temperature	TA	−20 to +75	°C
Storage Temperature	T <sub>stg</sub>	-55 to +125	°C

Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

#### Recommended Operating Range ( $T_A = -20 \text{ to } +75^{\circ}\text{C}$ , $V_{SS} = 0 \text{ V}$ )

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Logic Supply Voltage	V <sub>DD1</sub>	3.0	3.3	3.6	V
Driver Positive Supply Voltage	V <sub>DD2</sub>	15	23	25	V
Internal Operation Negative Supply Voltage	V <sub>EE1</sub>	<b>–15</b>	-10	-5.0	V
Power Supply Voltage	V <sub>DD2</sub> -V <sub>EE1</sub>	20	33	40	V
	VEE2-VEE1	0		6.0	V
Clock Frequency	fclk			100	kHz

#### Electrical Characteristics (TA = -20 to $+75^{\circ}$ C, VDD1 = 3.3 V $\pm 0.3$ V, VDD2 = 23 V, VEE1 = VEE2 = -10 V, Vss = 0 V)

Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
High-level Input Voltage	VIH	CLK, STVR (STVL), R,/L,	0.8 V <sub>DD1</sub>		V <sub>DD1</sub>	V
Low-level Input Voltage	VIL	OE1-OE3	Vss		0.2 V <sub>DD1</sub>	V
High-level Output Voltage	Vон	STVR (STVL), IoH = $-40 \mu$ A	V <sub>DD1</sub> - 0.4		V <sub>DD1</sub>	V
Low-level Output Voltage	Vol	STVR (STVL), $IoL = +40 \mu A$	Vss		Vss + 0.4	V
LCD Driver Output ON Resistance	Ron	Vout = VEE2 + 1.0 V, or VDD2 - 1.0 V		0.25	1.0	kΩ
Input Leak Current	lı∟	V <sub>I</sub> = 0 V or 3.6 V			±1.0	μΑ
Static Current Dissipation	I <sub>DD1</sub>	V <sub>DD1</sub> , f <sub>CLK</sub> = 50 kHz, OE <sub>1</sub> = OE <sub>2</sub> = OE <sub>3</sub> = L,		500	1000	μΑ
		fstv = 60 Hz, no load				
	I <sub>DD2</sub>	VDD2, fcLK = 50 kHz, OE1 = OE2 = OE3 = L,		50	100	μΑ
		fstv = 60 Hz, no load				
	lee	VEE1, fCLK = 50 kHz, OE1 = OE2 = OE3 = L, fSTV = 60 Hz, no load	-1100	<b>–</b> 550		μΑ

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### Switching Characteristics (TA = -20 to +75°C, VDD1 = 3.3 V $\pm$ 0.3 V, VDD2 = 23 V, VEE1 = VEE2 = -10 V, Vss = 0 V)

Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Cascade Output Delay Time	tphL1	C <sub>L</sub> = 20 pF,		240	800	ns
	t <sub>PLH1</sub>	$CLK \rightarrow STVL (STVR)$		240	800	ns
Driver Output Delay Time	tPHL2	$C_L = 300 \text{ pF}, CLK \rightarrow O_n$		240	800	ns
	tPLH2			240	800	ns
	tphL3	$C_L = 300 \text{ pF}, OE_n \rightarrow O_n$		240	800	ns
	t <sub>PLH3</sub>			240	800	ns
Output Rise Time	tтьн	C <sub>L</sub> = 300 pF			350	ns
Output Fall Time	tтнL				350	ns
Input Capacitance	Cı	T <sub>A</sub> = 25 °C		6.0	15	pF

#### Timing Requirements (TA = -20 to +75°C, VDD1 = 3.3 V $\pm$ 0.3 V, VDD2 = 23 V, VEE1 = VEE2 = -10 V, Vss = 0 V)

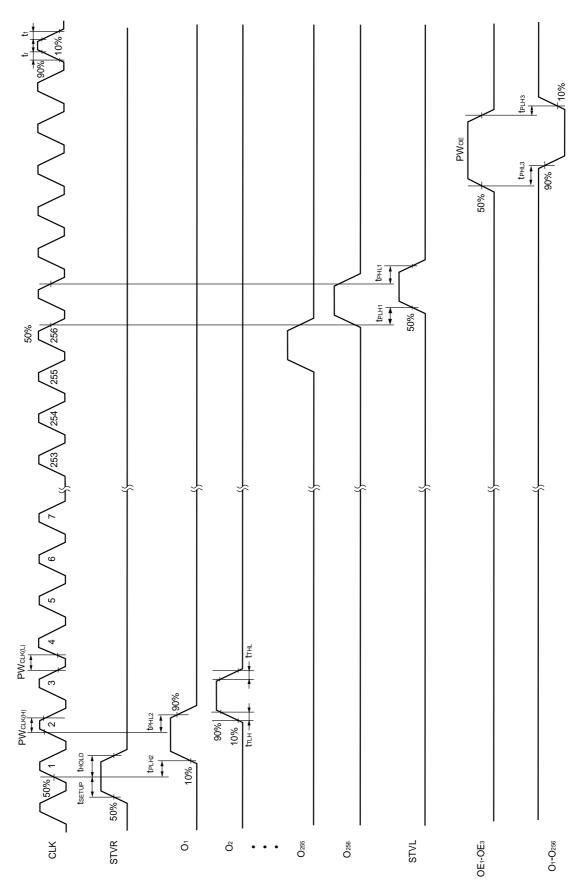
Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Clock Pulse High Width	PWclk(H)		500			ns
Clock Pulse Low Width	PW <sub>CLK(L)</sub>		500			ns
Enable Pulse Width	PWoE		1.0			μs
Data Setup Time	<b>t</b> SETUP	STVR (STVL) $\uparrow \rightarrow$ CLK $\uparrow$	200			ns
Data Hold Time	thold	$CLK \uparrow \to STVR(STVL) \downarrow$	200			ns

Caution Keep the time and fall time of the logic input to  $t_r = t_f = 20$  ns (10 to 90% of the rated values).

Remark Unless otherwise specified, the input level is defined to be VIH = 0.8 VDD1, VIL = 0.2 VDD1. For details, refer to Switching Characteristic Waveform.

#### Switching Characteristic Waveform (R,/L= H)

Unless otherwise specified, the input level is defined to be  $V_{IH} = 0.8 \text{ V}_{DD1}$ ,  $V_{IL} = 0.2 \text{ V}_{DD1}$ .





#### 6. RECOMMENDED MOUNTING CONDITIONS

The following conditions must be met for mounting conditions of the  $\mu$  PD16700.

For more details, refer to the Semiconductor Device Mounting Technology Manual (C10535E).

Please consult with our sales offices in case other mounting process is used, or in case the mounting is done under different conditions.

 $\mu$  PD16700N-xxx : TCP (TAB Package)

Mounting Condition	Mounting Method	Condition
Thermocompression	Soldering	Heating tool 300 to 350°C, heating for 2 to 3 seconds : pressure 100g
		(per solder)
	ACF	Temporary bonding 70 to 100°C: pressure 3 to 8 kg/cm <sup>2</sup> : time 3 to 5 sec.
	(Adhesive	Real bonding 165 to 180°C: pressure 25 to 45 kg/cm <sup>2</sup> : time 30 to 40 sec.
	Conductive Film)	(When using the anisotropy conductive film SUMIZAC1003 of
		Sumitomo Bakelite,Ltd).

Caution To find out the detailed conditions for mounting the ACF part, please contact the ACF manufacturing company. Be sure to avoid using two or more mounting methods at a time.

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[MEMO]

#### NOTES FOR CMOS DEVICES

#### 1 PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

#### 2 HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

#### **③ STATUS BEFORE INITIALIZATION OF MOS DEVICES**

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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#### **Reference Documents**

NEC Semiconductor Device Reliability/Quality Control System (C10983E)
Quality Grades to NEC's Semiconductor Devices (C11531E)

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